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Understanding **Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	125
Number of Gates	24000
Voltage - Supply	3V ~ 3.6V, 4.5V ~ 5.5V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 85°C (TA)
Package / Case	160-BQFP
Supplier Device Package	160-PQFP (28x28)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/a42mx16-pqg160i

Each I/O cell has three boundary-scan register cells, each with a serial-in, serial-out, parallel-in, and parallel-out pin. The serial pins are used to serially connect all the boundary-scan register cells in a device into a boundary-scan register chain, which starts at the TDI pin and ends at the TDO pin. The parallel ports are connected to the internal core logic tile and the input, output and control ports of an I/O buffer to capture and load data into the register to control or observe the logic state of each I/O.

Figure 14 • 42MX IEEE 1149.1 Boundary Scan Circuitry

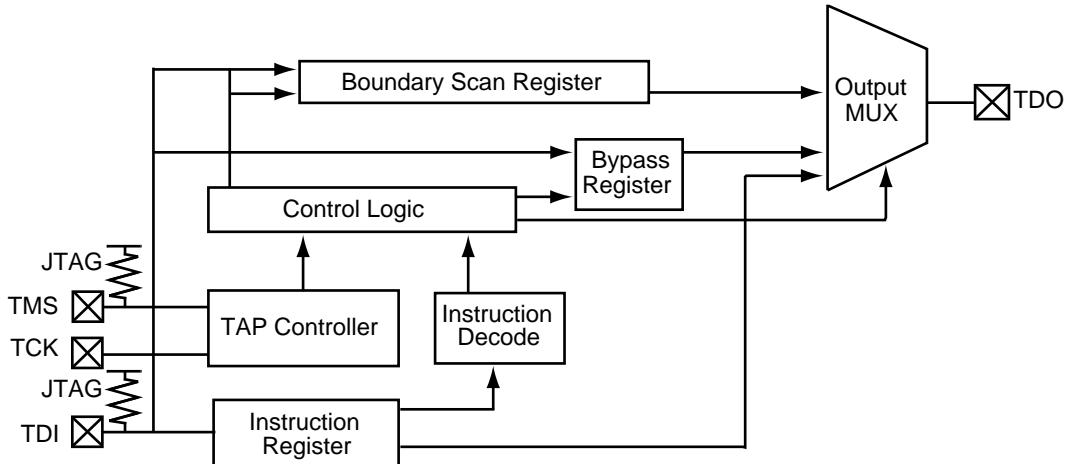


Table 9 • Test Access Port Descriptions

Port	Description
TMS (Test Mode Select)	Serial input for the test logic control bits. Data is captured on the rising edge of the test logic clock (TCK).
TCK (Test Clock Input)	Dedicated test logic clock used serially to shift test instruction, test data, and control inputs on the rising edge of the clock, and serially to shift the output data on the falling edge of the clock. The maximum clock frequency for TCK is 20 MHz.
TDI (Test Data Input)	Serial input for instruction and test data. Data is captured on the rising edge of the test logic clock.
TDO (Test Data Output)	Serial output for test instruction and data from the test logic. TDO is set to an Inactive Drive state (high impedance) when data scanning is not in progress.

Table 10 • Supported BST Public Instructions

Instruction	IR Code (IR2.IR0)	Instruction Type	Description
EXTEST	000	Mandatory	Allows the external circuitry and board-level interconnections to be tested by forcing a test pattern at the output pins and capturing test results at the input pins.
SAMPLE/PRELOAD	001	Mandatory	Allows a snapshot of the signals at the device pins to be captured and examined during operation
HIGH Z	101	Optional	Tristates all I/Os to allow external signals to drive pins. See the IEEE Standard 1149.1 specification.
CLAMP	110	Optional	Allows state of signals driven from component pins to be determined from the Boundary-Scan Register. See the IEEE Standard 1149.1 specification for details.
BYPASS	111	Mandatory	Enables the bypass register between the TDI and TDO pins. The test data passes through the selected device to adjacent devices in the test chain.

Note: *Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the recommended operating conditions.

Table 14 • Recommended Operating Conditions

Parameter	Commercial	Industrial	Military	Units
Temperature Range*	0 to +70	–40 to +85	–55 to +125	°C
VCC (40MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V
VCCA (42MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V
VCCI (42MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V

Note: * Ambient temperature (T_A) is used for commercial and industrial grades; case temperature (T_C) is used for military grades.

3.7.1 5 V TTL Electrical Specifications

The following tables show 5 V TTL electrical specifications.

Table 15 • 5V TTL Electrical Specifications

Symbol	Parameter	Commercial		Commercial -F		Industrial		Military		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
VOH ¹	IOH = –10 mA	2.4		2.4						V
	IOH = –4 mA					3.7		3.7		V
VOL ¹	IOL = 10 mA	0.5		0.5						V
	IOL = 6 mA					0.4		0.4		V
VIL		–0.3	0.8	–0.3	0.8	–0.3	0.8	–0.3	0.8	V
VIH (40MX)		2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	V
VIH (42MX) ²		2.0	VCCI + 0.3	2.0	VCCI + 0.3	2.0	VCCI + 0.3	2.0	VCCI + 0.3	V
IIL	VIN = 0.5 V	–10		–10		–10		–10		μA
IIH	VIN = 2.7 V	–10		–10		–10		–10		μA
Input Transition Time, T_R and T_F		500		500		500		500		ns
C_{IO} I/O Capacitance		10		10		10		10		pF
Standby Current, ICC^3	A40MX02, A40MX04	3		25		10		25		mA
	A42MX09	5		25		25		25		mA
	A42MX16	6		25		25		25		mA
	A42MX24, A42MX36	20		25		25		25		mA
Low power mode Standby Current	42MX devices only	0.5		ICC – 5.0		ICC – 5.0		ICC – 5.0		mA
IIO, I/O source sink current	Can be derived from the <i>IBIS model</i> (http://www.microsemi.com/soc/techdocs/models/ibis.html)									

1. Only one output tested at a time. VCC/VCCI = min

2. VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V

3. All outputs unloaded. All inputs = VCC/VCCI or GND

3.8 3.3 V Operating Conditions

The following table shows 3.3 V operating conditions.

Table 16 • Absolute Maximum Ratings for 40MX Devices*

Symbol	Parameter	Limits	Units
VCC	DC Supply Voltage	-0.5 to +7.0	V
VI	Input Voltage	-0.5 to VCC + 0.5	V
VO	Output Voltage	-0.5 to VCC + 0.5	V
t _{STG}	Storage Temperature	-65 to + 150	°C

Note: *Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the recommended operating conditions.

Table 17 • Absolute Maximum Ratings for 42MX Devices*

Symbol	Parameter	Limits	Units
VCCI	DC Supply Voltage for I/Os	-0.5 to +7.0	V
VCCA	DC Supply Voltage for Array	-0.5 to +7.0	V
VI	Input Voltage	-0.5 to VCCI+0.5	V
VO	Output Voltage	-0.5 to VCCI+0.5	V
t _{STG}	Storage Temperature	-65 to +150	°C

Note: *Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the recommended operating conditions.

Table 18 • Recommended Operating Conditions

Parameter	Commercial	Industrial	Military	Units
Temperature Range*	0 to +70	-40 to +85	-55 to +125	°C
VCC (40MX)	3.0 to 3.6	3.0 to 3.6	3.0 to 3.6	V
VCCA (42MX)	3.0 to 3.6	3.0 to 3.6	3.0 to 3.6	V
VCCI (42MX)	3.0 to 3.6	3.0 to 3.6	3.0 to 3.6	V

Note: *Ambient temperature (T_A) is used for commercial and industrial grades; case temperature (T_C) is used for military grades.

All the following tables show various specifications and operating conditions of 40MX and 42MX FPGAs.

A sample calculation of the absolute maximum power dissipation allowed for a TQ176 package at commercial temperature and still air is given in the following equation

$$\text{MaximumPowerAllowed} = \frac{\text{Max} \cdot \text{junction temp} \cdot (\text{°C}) - \text{Max} \cdot \text{ambient temp} \cdot (\text{°C})}{\theta_{ja}(\text{°C/W})} = \frac{150\text{°C} - 70\text{°C}}{(28\text{°C})/\text{W}} = 2.86\text{W}$$

EQ 5

The maximum power dissipation for military-grade devices is a function of θ_{jc} . A sample calculation of the absolute maximum power dissipation allowed for CQFP 208-pin package at military temperature and still air is given in the following equation

$$\text{MaximumPowerAllowed} = \frac{\text{Max} \cdot \text{junction temp} \cdot (\text{°C}) - \text{Max} \cdot \text{ambient temp} \cdot (\text{°C})}{\theta_{jc}(\text{°C/W})} = \frac{150\text{°C} - 125\text{°C}}{(6.3\text{°C})/\text{W}} = 3.97\text{W}$$

EQ 6

Table 27 • Package Thermal Characteristics

Plastic Packages	Pin Count	θ_{jc}	θ_{ja}			Units
			Still Air	1.0 m/s 200 ft/min.	2.5 m/s 500 ft/min.	
Plastic Quad Flat Pack	100	12.0	27.8	23.4	21.2	°C/W
Plastic Quad Flat Pack	144	10.0	26.2	22.8	21.1	°C/W
Plastic Quad Flat Pack	160	10.0	26.2	22.8	21.1	°C/W
Plastic Quad Flat Pack	208	8.0	26.1	22.5	20.8	°C/W
Plastic Quad Flat Pack	240	8.5	25.6	22.3	20.8	°C/W
Plastic Leaded Chip Carrier	44	16.0	20.0	24.5	22.0	°C/W
Plastic Leaded Chip Carrier	68	13.0	25.0	21.0	19.4	°C/W
Plastic Leaded Chip Carrier	84	12.0	22.5	18.9	17.6	°C/W
Thin Plastic Quad Flat Pack	176	11.0	24.7	19.9	18.0	°C/W
Very Thin Plastic Quad Flat Pack	80	12.0	38.2	31.9	29.4	°C/W
Very Thin Plastic Quad Flat Pack	100	10.0	35.3	29.4	27.1	°C/W
Plastic Ball Grid Array	272	3.0	18.3	14.9	13.9	°C/W
Ceramic Packages						
Ceramic Pin Grid Array	132	4.8	25.0	20.6	18.7	°C/W
Ceramic Quad Flat Pack	208	2.0	22.0	19.8	18.0	°C/W
Ceramic Quad Flat Pack	256	2.0	20.0	16.5	15.0	°C/W

Table 33 • Timing Parameters for 33 MHz PCI

Symbol	Parameter	PCI		A42MX24		A42MX36		Units
		Min.	Max.	Min.	Max.	Min.	Max.	
$t_{SU(PTP)}$	Input Set-Up Time to CLK—Point-to-Point	10, 12 ²	–	1.5	–	1.5	–	ns
t_H	Input Hold to CLK	0	–	0	–	0	–	ns

1. TOFF is system dependent. MX PCI devices have 7.4 ns turn-off time, reflection is typically an additional 10 ns.
 2. REQ# and GNT# are point-to-point signals and have different output valid delay and input setup times than do bussed signals. GNT# has a setup of 10; REW# has a setup of 12.

3.11.6.1 Timing Characteristics

The following tables list the timing characteristics.

**Table 34 • A40MX02 Timing Characteristics (Nominal 5.0 V Operation)
(Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C)**

Parameter / Description	–3 Speed		–2 Speed		–1 Speed		Std Speed		–F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Propagation Delays											
t_{PD1}	Single Module	1.2	1.4	1.6	1.9	2.7	ns				
t_{PD2}	Dual-Module Macros	2.7	3.1	3.5	4.1	5.7	ns				
t_{CO}	Sequential Clock-to-Q	1.2	1.4	1.6	1.9	2.7	ns				
t_{GO}	Latch G-to-Q	1.2	1.4	1.6	1.9	2.7	ns				
t_{RS}	Flip-Flop (Latch) Reset-to-Q	1.2	1.4	1.6	1.9	2.7	ns				
Logic Module Predicted Routing Delays¹											
t_{RD1}	FO = 1 Routing Delay	1.3	1.5	1.7	2.0	2.8	ns				
t_{RD2}	FO = 2 Routing Delay	1.8	2.1	2.4	2.8	3.9	ns				
t_{RD3}	FO = 3 Routing Delay	2.3	2.7	3.0	3.6	5.0	ns				
t_{RD4}	FO = 4 Routing Delay	2.9	3.3	3.7	4.4	6.1	ns				
t_{RD8}	FO = 8 Routing Delay	4.9	5.7	6.5	7.6	10.6	ns				
Logic Module Sequential Timing²											
t_{SUD}	Flip-Flop (Latch) Data Input Set-Up	3.1	3.5	4.0	4.7	6.6	ns				
t_{HD}^3	Flip-Flop (Latch) Data Input Hold	0.0	0.0	0.0	0.0	0.0	ns				
t_{SUENA}	Flip-Flop (Latch) Enable Set-Up	3.1	3.5	4.0	4.7	6.6	ns				
t_{HEN}	Flip-Flop (Latch) Enable Hold	0.0	0.0	0.0	0.0	0.0	ns				
t_{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	3.3	3.8	4.3	5.0	7.0	ns				
t_{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	3.3	3.8	4.3	5.0	7.0	ns				
t_A	Flip-Flop Clock Input Period	4.8	5.6	6.3	7.5	10.4	ns				
f_{MAX}	Flip-Flop (Latch) Clock Frequency (FO = 128)	181	168	154	134	80	MHz				

Table 34 • A40MX02 Timing Characteristics (Nominal 5.0 V Operation) (continued)
(Worst-Case Commercial Conditions, VCC = 4.75 V, TJ = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
TTL Output Module Timing⁴											
t _{DLH}	Data-to-Pad HIGH	3.3	3.8	4.3	5.1	7.2	ns				
t _{DHL}	Data-to-Pad LOW	4.0	4.6	5.2	6.1	8.6	ns				
t _{ENZH}	Enable Pad Z to HIGH	3.7	4.3	4.9	5.8	8.0	ns				
t _{ENZL}	Enable Pad Z to LOW	4.7	5.4	6.1	7.2	10.1	ns				
t _{ENHZ}	Enable Pad HIGH to Z	7.9	9.1	10.4	12.2	17.1	ns				
t _{ENLZ}	Enable Pad LOW to Z	5.9	6.8	7.7	9.0	12.6	ns				
d _{TLH}	Delta LOW to HIGH	0.02	0.02	0.03	0.03	0.04	ns/pF				
d _{THL}	Delta HIGH to LOW	0.03	0.03	0.03	0.04	0.06	ns/pF				
CMOS Output Module Timing⁴											
t _{DLH}	Data-to-Pad HIGH	3.9	4.5	5.1	6.05	8.5	ns				
t _{DHL}	Data-to-Pad LOW	3.4	3.9	4.4	5.2	7.3	ns				
t _{ENZH}	Enable Pad Z to HIGH	3.4	3.9	4.4	5.2	7.3	ns				
t _{ENZL}	Enable Pad Z to LOW	4.9	5.6	6.4	7.5	10.5	ns				
t _{ENHZ}	Enable Pad HIGH to Z	7.9	9.1	10.4	12.2	17.0	ns				
t _{ENLZ}	Enable Pad LOW to Z	5.9	6.8	7.7	9.0	12.6	ns				
d _{TLH}	Delta LOW to HIGH	0.03	0.04	0.04	0.05	0.07	ns/pF				
d _{THL}	Delta HIGH to LOW	0.02	0.02	0.03	0.03	0.04	ns/pF				

1. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance
2. Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility
3. The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer tool from the Designer software to check the hold time for this macro.
4. Delays based on 35pF loading

Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCC = 3.0 V, TJ = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Propagation Delays											
t _{PD1}	Single Module	1.7	2.0	2.3	2.7	3.7	ns				
t _{PD2}	Dual-Module Macros	3.7	4.3	4.9	5.7	8.0	ns				
t _{CO}	Sequential Clock-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
t _{GO}	Latch G-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
t _{RS}	Flip-Flop (Latch) Reset-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
Logic Module Predicted Routing Delays¹											

Table 38 • A42MX09 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, TJ = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
CMOS Output Module Timing⁵											
t _{DLH}	Data-to-Pad HIGH		2.4		2.7		3.1		3.6		5.1 ns
t _{DHL}	Data-to-Pad LOW		2.9		3.2		3.6		4.3		6.0 ns
t _{ENZH}	Enable Pad Z to HIGH		2.7		2.9		3.3		3.9		5.5 ns
t _{ENZL}	Enable Pad Z to LOW		2.9		3.2		3.7		4.3		6.1 ns
t _{ENHZ}	Enable Pad HIGH to Z		4.9		5.4		6.2		7.3		10.2 ns
t _{ENLZ}	Enable Pad LOW to Z		5.3		5.9		6.7		7.9		11.1 ns
t _{GLH}	G-to-Pad HIGH		4.2		4.6		5.2		6.1		8.6 ns
t _{GHL}	G-to-Pad LOW		4.2		4.6		5.2		6.1		8.6 ns
t _{LSU}	I/O Latch Set-Up	0.5		0.5		0.6		0.7		1.0	ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0	ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading		5.2		5.8		6.6		7.7		10.8 ns
t _{ACO}	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading		7.4		8.2		9.3		10.9		15.3 ns
d _{TLH}	Capacity Loading, LOW to HIGH	0.03		0.03		0.03		0.04		0.06	ns/pF
d _{THL}	Capacity Loading, HIGH to LOW	0.04		0.04		0.04		0.05		0.07	ns/pF

- For dual-module macros, use $t_{PD1} + t_{RD1} + t_{PDn}$, $t_{CO} + t_{RD1} + t_{PDn}$, or $t_{PD1} + t_{RD1} + t_{SUD}$, whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
- Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- Set-up and hold timing parameters for the input buffer latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
- Delays based on 35 pF loading

Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Propagation Delays¹											
t _{PD1}	Single Module	1.6		1.8		2.1		2.5		3.5	ns
t _{CO}	Sequential Clock-to-Q	1.8		2.0		2.3		2.7		3.8	ns
t _{GO}	Latch G-to-Q	1.7		1.9		2.1		2.5		3.5	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q	2.0		2.2		2.5		2.9		4.1	ns
Logic Module Predicted Routing Delays²											
t _{RD1}	FO = 1 Routing Delay	1.0		1.1		1.2		1.4		2.0	ns
t _{RD2}	FO = 2 Routing Delay	1.3		1.4		1.6		1.9		2.7	ns
t _{RD3}	FO = 3 Routing Delay	1.6		1.8		2.0		2.4		3.3	ns

Table 43 • A42MX24 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)

Parameter / Description		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed	
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.
TTL Output Module Timing⁵ (continued)											
t _{LH}	I/O Latch Output Hold	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	ns	
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.7	8.5	9.6		11.3		15.9	ns	
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		14.8	16.5	18.7		22.0		30.8	ns	
d _{TLH}	Capacitive Loading, LOW to HIGH	0.05	0.05	0.06	0.07		0.10	ns/pF			
d _{THL}	Capacitive Loading, HIGH to LOW	0.04	0.04	0.05	0.06		0.08	ns/pF			
CMOS Output Module Timing⁵											
t _{DLH}	Data-to-Pad HIGH	4.8	5.3	5.5	6.4		9.0	ns			
t _{DHL}	Data-to-Pad LOW	3.5	3.9	4.1	4.9		6.8	ns			
t _{ENZH}	Enable Pad Z to HIGH	3.6	4.0	4.5	5.3		7.4	ns			
t _{ENZL}	Enable Pad Z to LOW	3.4	4.0	5.0	5.8		8.2	ns			
t _{ENHZ}	Enable Pad HIGH to Z	7.2	8.0	9.0	10.7		14.9	ns			
t _{ENLZ}	Enable Pad LOW to Z	6.7	7.5	8.5	9.9		13.9	ns			
t _{GLH}	G-to-Pad HIGH	6.8	7.6	8.6	10.1		14.2	ns			
t _{GHL}	G-to-Pad LOW	6.8	7.6	8.6	10.1		14.2	ns			
t _{LSU}	I/O Latch Set-Up	0.7	0.7	0.8	1.0		1.4	ns			
t _{LH}	I/O Latch Hold	0.0	0.0	0.0	0.0		0.0	ns			
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.7	8.5	9.6		11.3		15.9	ns	
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		14.8	16.5	18.7		22.0		30.8	ns	
d _{TLH}	Capacitive Loading, LOW to HIGH	0.05	0.05	0.06	0.07		0.10	ns/pF			
d _{THL}	Capacitive Loading, HIGH to LOW	0.04	0.04	0.05	0.06		0.08	ns/pF			
t _{HEXT}	Input Latch External Hold	FO = 32 FO = 486	3.9 4.6	4.3 5.2	4.9 5.8		5.7 6.9	8.1 9.6	ns ns		
t _P	Minimum Period (1/f _{MAX})	FO = 32 FO = 486	7.8 8.6	8.7 9.5	9.5 10.4		10.8 11.9	18.2 19.9	ns ns		

- For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn}, t_{CO} + t_{RD1} + t_{PDn}, or t_{PD1} + t_{RD1} + t_{SUP}, whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
- Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
- Delays based on 35 pF loading.

Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Input Module Predicted Routing Delays²											
t _{IRD1}	FO = 1 Routing Delay		2.8	3.1	3.5	4.1	5.7	ns			
t _{IRD2}	FO = 2 Routing Delay		3.2	3.5	4.1	4.8	6.7	ns			
t _{IRD3}	FO = 3 Routing Delay		3.7	4.1	4.7	5.5	7.7	ns			
t _{IRD4}	FO = 4 Routing Delay		4.2	4.6	5.3	6.2	8.7	ns			
t _{IRD8}	FO = 8 Routing Delay		6.1	6.8	7.7	9.0	12.6	ns			
Global Clock Network											
t _{CKH}	Input LOW to HIGH	FO = 32	4.6	5.1	5.7	6.7	9.3	ns			
		FO = 635	5.0	5.6	6.3	7.4	10.3	ns			
t _{CKL}	Input HIGH to LOW	FO = 32	5.3	5.9	6.7	7.8	11.0	ns			
		FO = 635	6.8	7.6	8.6	10.1	14.1	ns			
t _{PWH}	Minimum Pulse Width HIGH	FO = 32	2.5	2.7	3.1	3.6	5.1	ns			
		FO = 635	2.8	3.1	3.5	4.1	5.7	ns			
t _{PWL}	Minimum Pulse Width LOW	FO = 32	2.5	2.7	3.1	3.6	5.1	ns			
		FO = 635	2.8	3.1	3.5	4.1	5.7	ns			
t _{CKSW}	Maximum Skew	FO = 32	1.0	1.2	1.3	1.5	2.2	ns			
		FO = 635	1.0	1.2	1.3	1.5	2.2	ns			
t _{SUEXT}	Input Latch External Set-Up	FO = 32	0.0	0.0	0.0	0.0	0.0	ns			
		FO = 635	0.0	0.0	0.0	0.0	0.0	ns			
t _{HEXT}	Input Latch External Hold	FO = 32	4.0	4.4	5.0	5.9	8.2	ns			
		FO = 635	4.6	5.2	5.9	6.9	9.6	ns			
t _P	Minimum Period (1/f _{MAX})	FO = 32	9.2	10.2	11.1	12.7	21.2	ns			
		FO = 635	9.9	11.0	12.0	13.8	23.0	ns			
f _{MAX}	Maximum Datapath Frequency	FO = 32	108	98	90	79	47	MHz			
		FO = 635	100	91	83	73	44	MHz			
TTL Output Module Timing⁵											
t _{DLH}	Data-to-Pad HIGH		3.6	4.0	4.5	5.3	7.4	ns			
t _{DHL}	Data-to-Pad LOW		4.2	4.6	5.2	6.2	8.6	ns			
t _{ENZH}	Enable Pad Z to HIGH		3.7	4.2	4.7	5.5	7.7	ns			
t _{ENZL}	Enable Pad Z to LOW		4.1	4.6	5.2	6.1	8.5	ns			
t _{ENHZ}	Enable Pad HIGH to Z		7.34	8.2	9.3	10.9	15.3	ns			
TTL Output Module Timing⁵											
t _{ENLZ}	Enable Pad LOW to Z		6.9	7.6	8.7	10.2	14.3	ns			
t _{GLH}	G-to-Pad HIGH		4.9	5.5	6.2	7.3	10.2	ns			
t _{GHL}	G-to-Pad LOW		4.9	5.5	6.2	7.3	10.2	ns			
t _{LSU}	I/O Latch Output Set-Up		0.7	0.7	0.8	1.0	1.4	ns			
t _{LH}	I/O Latch Output Hold		0.0	0.0	0.0	0.0	0.0	ns			
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.9	8.8	10.0	11.8	16.5	ns			

4 Package Pin Assignments

The following figures and tables give the details of the package pin assignments.

Figure 38 • PL44

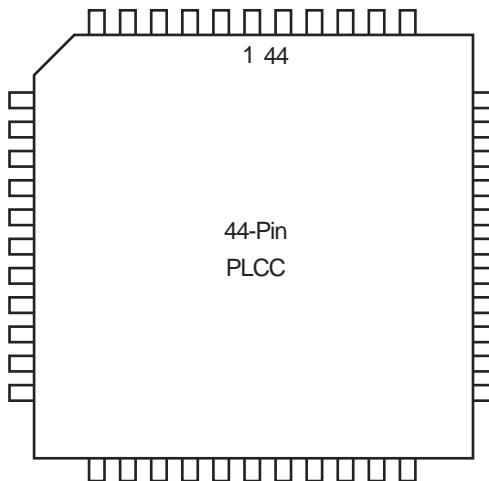


Table 47 • PL44

PL44		
Pin Number	A40MX02 Function	A40MX04 Function
1	I/O	I/O
2	I/O	I/O
3	VCC	VCC
4	I/O	I/O
5	I/O	I/O
6	I/O	I/O
7	I/O	I/O
8	I/O	I/O
9	I/O	I/O
10	GND	GND
11	I/O	I/O
12	I/O	I/O
13	I/O	I/O
14	VCC	VCC
15	I/O	I/O
16	VCC	VCC
17	I/O	I/O
18	I/O	I/O
19	I/O	I/O
20	I/O	I/O

Table 50 • PQ 100

PQ100	Pin Number	A40MX02 Function	A40MX04 Function	A42MX09 Function	A42MX16 Function
56	VCC	VCC	I/O	I/O	
57	I/O	I/O	GND	GND	
58	I/O	I/O	I/O	I/O	
59	I/O	I/O	I/O	I/O	
60	I/O	I/O	I/O	I/O	
61	I/O	I/O	I/O	I/O	
62	I/O	I/O	I/O	I/O	
63	GND	GND	I/O	I/O	
64	I/O	I/O	LP	LP	
65	I/O	I/O	VCCA	VCCA	
66	I/O	I/O	VCCI	VCCI	
67	I/O	I/O	VCCA	VCCA	
68	I/O	I/O	I/O	I/O	
69	VCC	VCC	I/O	I/O	
70	I/O	I/O	I/O	I/O	
71	I/O	I/O	I/O	I/O	
72	I/O	I/O	GND	GND	
73	I/O	I/O	I/O	I/O	
74	I/O	I/O	I/O	I/O	
75	I/O	I/O	I/O	I/O	
76	I/O	I/O	I/O	I/O	
77	NC	NC	I/O	I/O	
78	NC	NC	I/O	I/O	
79	NC	NC	SDI, I/O	SDI, I/O	
80	NC	I/O	I/O	I/O	
81	NC	I/O	I/O	I/O	
82	NC	I/O	I/O	I/O	
83	I/O	I/O	I/O	I/O	
84	I/O	I/O	GND	GND	
85	I/O	I/O	I/O	I/O	
86	GND	GND	I/O	I/O	
87	GND	GND	PRA, I/O	PRA, I/O	
88	I/O	I/O	I/O	I/O	
89	I/O	I/O	CLKA, I/O	CLKA, I/O	
90	CLK, I/O	CLK, I/O	VCCA	VCCA	
91	I/O	I/O	I/O	I/O	
92	MODE	MODE	CLKB, I/O	CLKB, I/O	

Table 51 • PQ144

PQ144	
Pin Number	A42MX09 Function
80	GNDI
81	NC
82	I/O
83	I/O
84	I/O
85	I/O
86	I/O
87	I/O
88	VKS
89	VPP
90	VCC
91	VCCI
92	NC
93	VSV
94	I/O
95	I/O
96	I/O
97	I/O
98	I/O
99	I/O
100	GND
101	GNDI
102	NC
103	I/O
104	I/O
105	I/O
106	I/O
107	I/O
108	I/O
109	I/O
110	SDI
111	I/O
112	I/O
113	I/O
114	I/O
115	I/O
116	GNDQ

Table 52 • PQ160

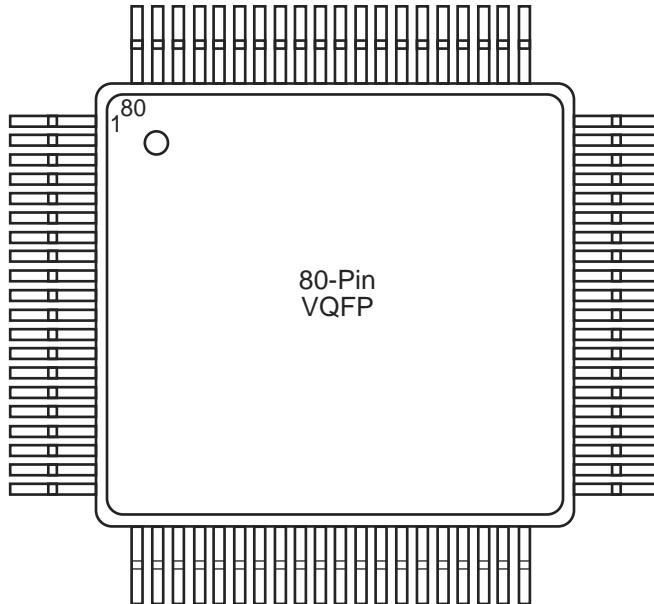
PQ160	Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
	132	I/O	I/O	I/O
	133	I/O	I/O	I/O
	134	I/O	I/O	I/O
	135	NC	VCCA	VCCA
	136	I/O	I/O	I/O
	137	I/O	I/O	I/O
	138	NC	VCCA	VCCA
	139	VCCI	VCCI	VCCI
	140	GND	GND	GND
	141	NC	I/O	I/O
	142	I/O	I/O	I/O
	143	I/O	I/O	I/O
	144	I/O	I/O	I/O
	145	GND	GND	GND
	146	NC	I/O	I/O
	147	I/O	I/O	I/O
	148	I/O	I/O	I/O
	149	I/O	I/O	I/O
	150	NC	VCCA	VCCA
	151	NC	I/O	I/O
	152	NC	I/O	I/O
	153	NC	I/O	I/O
	154	NC	I/O	I/O
	155	GND	GND	GND
	156	I/O	I/O	I/O
	157	I/O	I/O	I/O
	158	I/O	I/O	I/O
	159	MODE	MODE	MODE
	160	GND	GND	GND

Table 53 • PQ208

PQ208	Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
	95	NC	I/O	I/O
	96	NC	I/O	I/O
	97	NC	I/O	I/O
	98	VCCI	VCCI	VCCI
	99	I/O	I/O	I/O
	100	I/O	WD, I/O	WD, I/O
	101	I/O	WD, I/O	WD, I/O
	102	I/O	I/O	I/O
	103	SDO, I/O	SDO, TDO, I/O	SDO, TDO, I/O
	104	I/O	I/O	I/O
	105	GND	GND	GND
	106	NC	VCCA	VCCA
	107	I/O	I/O	I/O
	108	I/O	I/O	I/O
	109	I/O	I/O	I/O
	110	I/O	I/O	I/O
	111	I/O	I/O	I/O
	112	NC	I/O	I/O
	113	NC	I/O	I/O
	114	NC	I/O	I/O
	115	NC	I/O	I/O
	116	I/O	I/O	I/O
	117	I/O	I/O	I/O
	118	I/O	I/O	I/O
	119	I/O	I/O	I/O
	120	I/O	I/O	I/O
	121	I/O	I/O	I/O
	122	I/O	I/O	I/O
	123	I/O	I/O	I/O
	124	I/O	I/O	I/O
	125	I/O	I/O	I/O
	126	GND	GND	GND
	127	I/O	I/O	I/O
	128	I/O	TCK, I/O	TCK, I/O
	129	LP	LP	LP
	130	VCCA	VCCA	VCCA
	131	GND	GND	GND

Table 54 • PQ240

PQ240	
Pin Number	A42MX36 Function
237	GND
238	MODE
239	VCCA
240	GND

Figure 46 • VQ80**Table 55 • VQ80**

VQ80		
Pin Number	A40MX02 Function	A40MX04 Function
1	I/O	I/O
2	NC	I/O
3	NC	I/O
4	NC	I/O
5	I/O	I/O
6	I/O	I/O
7	GND	GND
8	I/O	I/O
9	I/O	I/O
10	I/O	I/O
11	I/O	I/O
12	I/O	I/O

Table 57 • TQ176

TQ176	Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
	121	NC	NC	I/O
	122	I/O	I/O	I/O
	123	I/O	I/O	I/O
	124	NC	I/O	I/O
	125	NC	I/O	I/O
	126	NC	NC	I/O
	127	I/O	I/O	I/O
	128	I/O	I/O	I/O
	129	I/O	I/O	I/O
	130	I/O	I/O	I/O
	131	I/O	I/O	I/O
	132	I/O	I/O	I/O
	133	GND	GND	GND
	134	I/O	I/O	I/O
	135	SDI, I/O	SDI, I/O	SDI, I/O
	136	NC	I/O	I/O
	137	I/O	I/O	WD, I/O
	138	I/O	I/O	WD, I/O
	139	I/O	I/O	I/O
	140	NC	VCCI	VCCI
	141	I/O	I/O	I/O
	142	I/O	I/O	I/O
	143	NC	I/O	I/O
	144	NC	I/O	WD, I/O
	145	NC	NC	WD, I/O
	146	I/O	I/O	I/O
	147	NC	I/O	I/O
	148	I/O	I/O	I/O
	149	I/O	I/O	I/O
	150	I/O	I/O	WD, I/O
	151	NC	I/O	WD, I/O
	152	PRA, I/O	PRA, I/O	PRA, I/O
	153	I/O	I/O	I/O
	154	CLKA, I/O	CLKA, I/O	CLKA, I/O
	155	VCCA	VCCA	VCCA
	156	GND	GND	GND
	157	I/O	I/O	I/O

Table 58 • CQ208

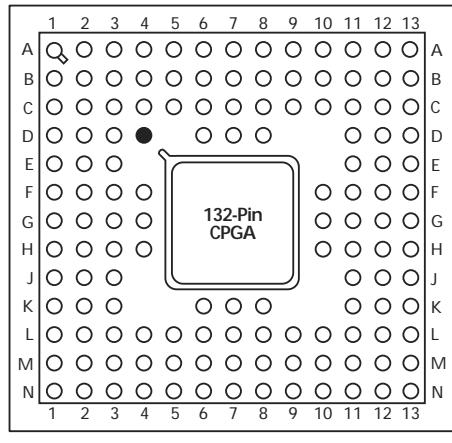
CQ208	
Pin Number	A42MX36 Function
185	I/O
186	CLKB, I/O
187	I/O
188	PRB, I/O
189	I/O
190	WD, I/O
191	WD, I/O
192	I/O
193	I/O
194	WD, I/O
195	WD, I/O
196	QCLKC, I/O
197	I/O
198	I/O
199	I/O
200	I/O
201	I/O
202	VCCI
203	WD, I/O
204	WD, I/O
205	I/O
206	I/O
207	DCLK, I/O
208	I/O

Table 59 • CQ256

CQ256	
Pin Number	A42MX36 Function
22	I/O
23	I/O
24	I/O
25	I/O
26	VCCA
27	I/O
28	I/O
29	VCCA
30	VCCI
31	GND
32	VCCA
33	LP
34	TCK, I/O
35	I/O
36	GND
37	I/O
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	I/O
45	I/O
46	I/O
47	I/O
48	GND
49	I/O
50	I/O
51	I/O
52	I/O
53	I/O
54	I/O
55	I/O
56	I/O
57	I/O
58	I/O

Table 60 • BG272

BG272	
Pin Number	A42MX36 Function
Y13	I/O
Y14	I/O
Y15	I/O
Y16	I/O
Y17	I/O
Y18	WD, I/O
Y19	GND
Y20	GND

Figure 52 • PG132

● Orientation Pin

Table 61 • PG132

PG132	
Pin Number	A42MX09 Function
-	PMPOUT
B2	I/O
A1	MODE
B1	I/O
D3	I/O
C2	I/O
C1	I/O
D2	I/O
D1	I/O
E2	I/O
E1	I/O
F3	I/O

Table 61 • PG132

PG132	
Pin Number	A42MX09 Function
B3	I/O
A2	I/O
C3	DCLK
B5	GNDA
E12	GNDA
J2	GNDA
M9	GNDA
B9	GNDI
C5	GNDI
E11	GNDI
F4	GNDI
J3	GNDI
J11	GNDI
L5	GNDI
L9	GNDI
C9	GNDQ
E3	GNDQ
K12	GNDQ
D7	VCCA
G3	VCCA
G10	VCCA
L7	VCCA
C7	VCCI
G2	VCCI
G11	VCCI
K7	VCCI